

Search Notes

Application/Control No.

09/593,891

Examiner

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Applicant(s)/Patent under
Reexamination

NAKAYAMA, SADA O

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	686, 692, 777, 778, 780 & 730	6/6/2005	C.C.
257	725 & 723	6/6/2005	C.C.
438	108 & 109	6/6/2005	C.C.
361	760	6/6/2005	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
AS SAME	AS ABOVE	6/6/2005	C.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	6/6/2005	C.C.